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STW56N60DM2

N-channel 600 V, 0.052 Ω typ., 50 A MDmesh™ DM2 Power MOSFET in a TO-247 package

Datasheet - production data

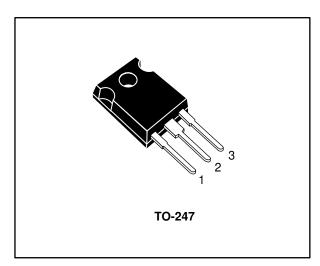
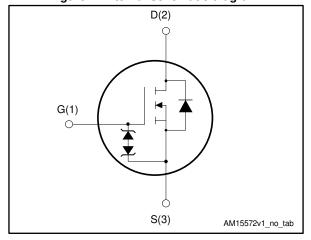


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	P _{TOT}
STW56N60DM2	600 V	0.060 Ω	50 A	360 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

• Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmeshTM DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STW56N60DM2	56N60DM2	TO-247	Tube

Contents STW56N60DM2

Contents

1	Electric	cal ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Packag	e information	9
	4.1	TO-247 package information	9
5	Revisio	n history	11

STW56N60DM2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	±25	V
	Drain current (continuous) at T _{case} = 25 °C	50	۸
I _D	Drain current (continuous) at T _{case} = 100 °C	31	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	200	Α
P _{TOT}	Total dissipation at T _{case} = 25 °C	360	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/IIS
T _{stg}	Storage temperature	FF to 1F0	°C
Tj	Operating junction temperature	-55 to 150	°C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.35	0C AM
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AS} ⁽¹⁾	Avalanche current, repetitive or not repetitive	12	Α
E _{AS} ⁽²⁾	Single pulse avalanche energy	800	mJ

Notes:

 $^{^{\}left(1\right)}$ Pulse width is limited by safe operating area.

 $^{^{(2)}}$ $I_{SD} \leq$ 50 A, di/dt=900 A/µs; V_{DS} peak < $V_{(BR)DSS},~V_{DD}$ = 400 V.

 $^{^{(3)}}$ V_{DS} ≤ 480 V.

 $^{^{\}left(1\right)}$ Pulse width limited by $T_{jmax}.$

 $^{^{(2)}}$ starting T_{j} = 25 °C, I_{D} = $I_{AS},\ V_{DD}$ = 50 V.

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			>
	Zaro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			10	
I _{DSS}	I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{case} = 125 \text{ °C}$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±5	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS}=V_{GS},I_D=250\;\mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 25 A		0.052	0.060	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		1	4100	1	
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	1	190	1	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	ı	3.2	ı	ρ.
Coss eq.	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	325	-	pF
R_{G}	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	4.2	-	Ω
Q_g	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 50 \text{ A},$	-	90	-	
Q _{gs}	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15</i> :	-	18	-	nC
Q_{gd}	Gate-drain charge	"Gate charge test circuit")	-	44	-	

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 25 \text{ A}$	1	24	-	
t _r	Rise time	$R_G = 4.7 \Omega$ (see Figure 14: "Switching times test circuit	ı	60	-	
t _{d(off)}	Turn-off delay time	for resistive load" and	ı	130	-	ns
t _f	Fall time	Figure 19: "Switching time waveform")	-	12	-	

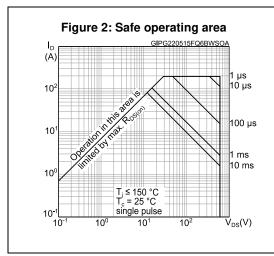
Table 8: Source-drain diode

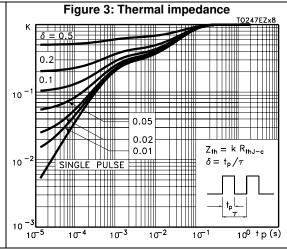
Symbo I	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		1		50	Α
I _{SDM}	Source-drain current (pulsed)		-		200	Α
V _{SD} ⁽¹⁾	Forward on voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 50 \text{ A}$	1		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 50 \text{ A},$	1	140		ns
Qrr	Reverse recovery charge	di/dt = 100 A/ μ s, V _{DD} = 60 V (see <i>Figure 16</i> :	1	0.7		μC
I _{RRM}	Reverse recovery current	"Test circuit for inductive load switching and diode recovery times")	ı	10.6		Α
t _{rr}	Reverse recovery time	$I_{SD} = 50 A,$	1	245		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/μs, V _{DD} = 60 V, T _i = 150 °C	-	2.6		μC
I _{RRM}	Reverse recovery current	(see Figure 16: "Test circuit for inductive load switching and diode recovery times")	•	21		Α

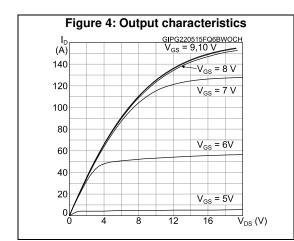
Notes:

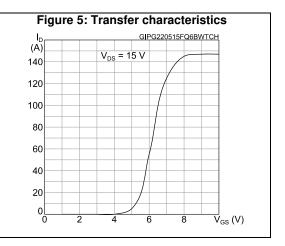
 $^{^{(1)}}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

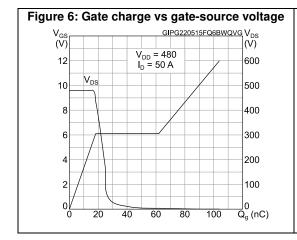
2.1 Electrical characteristics (curves)

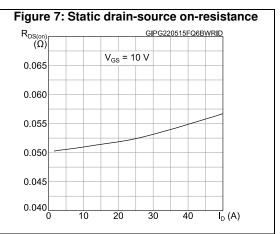












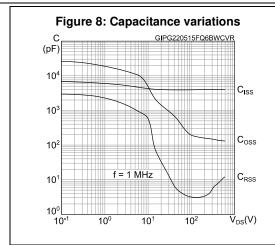


Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG220515FQ6BWRON
(norm.)

2.2

1.8

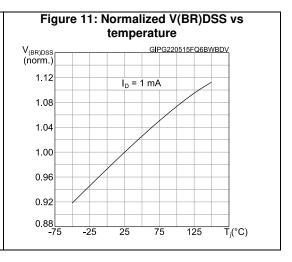
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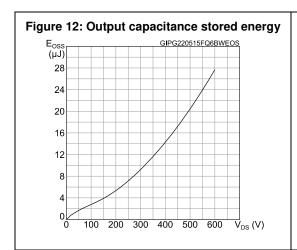
1.0

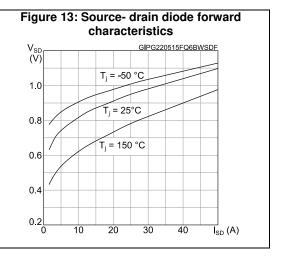
0.6

0.2

-75
-25
25
75
125
T_j (°C)

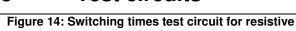


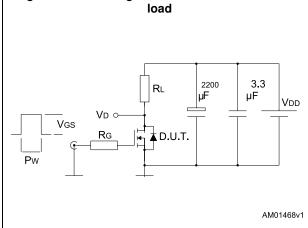




Test circuits STW56N60DM2

3 Test circuits





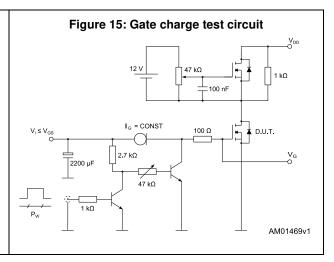


Figure 16: Test circuit for inductive load switching and diode recovery times

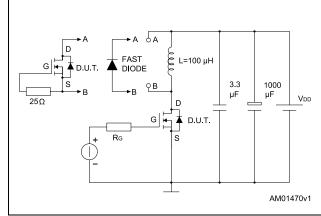
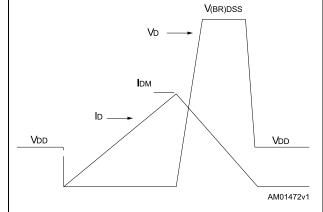
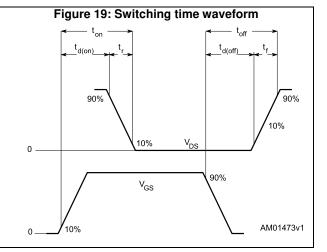


Figure 18: Unclamped inductive waveform





4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

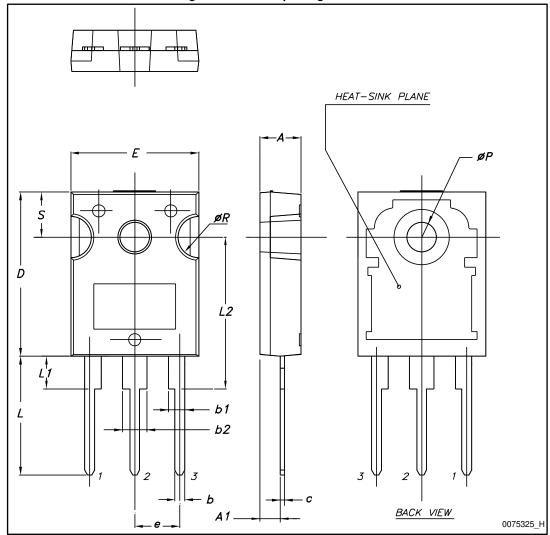


Figure 20: TO-247 package outline

Table 9: TO-247 package mechanical data

Di	·	mm.	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW56N60DM2 Revision history

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
08-Oct-2014	1	First release.
09-Jun-2015	2	Text and formatting changes throughout document. On cover page: - updated title description and features In Section 1 Electrcial ratings: - updated Table 2. Absolute maximum ratings - updated Table 4. Avalanche characteristics In Section 2 Electrical characteristics: - updated and renamed Table 5. Static (was On /off states) - updated Table 6. Dynamic - updated Table 7. Switching times - updated Table 8. Source drain diode Added Section 2.1 Electrical characteristics (curves)
15-Jun-2015	3	Datasheet promoted from preliminary data to production data

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